



DMP2067LVT

## **Product Summary**

BV <sub>DSS</sub>	R <sub>DS(ON)</sub> Max	I <sub>D</sub> Max T <sub>A</sub> = +25°C
-20V	45mΩ @ V <sub>GS</sub> = -4.5V	-4.2A
-200	65mΩ @ V <sub>GS</sub> = -2.5V	-3.5A

## Description

This new generation MOSFET is designed to minimize the on-state resistance ( $R_{DS(ON)}$ ), and yet maintain superior switching performance, making it ideal for high-efficiency power management applications.

# **Applications**

- General Purpose Interfacing Switch
- Power Management Functions

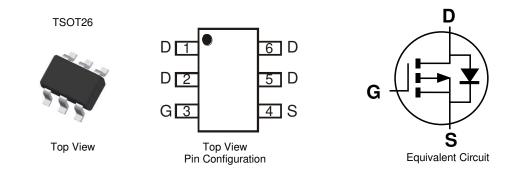
### P-CHANNEL ENHANCEMENT MODE MOSFET

# **Features and Benefits**

- Low On-Resistance
- Low Gate Threshold Voltage
- Low Input Capacitance
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

## **Mechanical Data**

- Case: TSOT26
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Tin Finish Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208 (3)
- Weight: 0.013 grams (Approximate)



## Ordering Information (Note 4)

Part Number	Case	Packaging
DMP2067LVT-7	TSOT26	3,000/Tape & Reel
DMP2067LVT-13	TSOT26	10,000/Tape & Reel

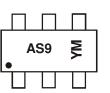
Notes: 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant. 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green"

and Lead-free.

3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.</p>

4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

# **Marking Information**



 $\begin{array}{l} AS9 = Product \mbox{ Type Marking Code} \\ YM = Date \mbox{ Code Marking} \\ Y \mbox{ or } \overline{Y} = Year \mbox{ (ex: F = 2018)} \end{array}$ 

M = Month (ex: 9 = September)

Year	2018	2019	20	020	2021	2022	2	2023	2024	202	25	2026
Code	F	G		H		J		K	L	N	1	Ν
Month	Jan	Feb	Mar	Apr	Мау	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



# **Maximum Ratings** (@ $T_A = +25^{\circ}C$ , unless otherwise specified.)

Characteristic		Symbol	Value	Unit
Drain-Source Voltage		V <sub>DSS</sub>	-20	V
Gate-Source Voltage		V <sub>GSS</sub>	±8	V
Drain Current (Note 5) Continuous	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	ID	-4.2 -3.4	A
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1	1%)	I <sub>DM</sub>	-30	A
Body-Diode Continuous Current (Note 5)		IS	-1.4	А

# Thermal Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Unit
Total Power Dissipation (Note 5)		PD	1.2	W
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	R <sub>0JA</sub>	105	°C/W
Total Power Dissipation (Note 6)		PD	1.6	W
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	R <sub>0JA</sub>	78	°C/W
Operating and Storage Temperature Range		TJ, TSTG	-55 to +150	°C

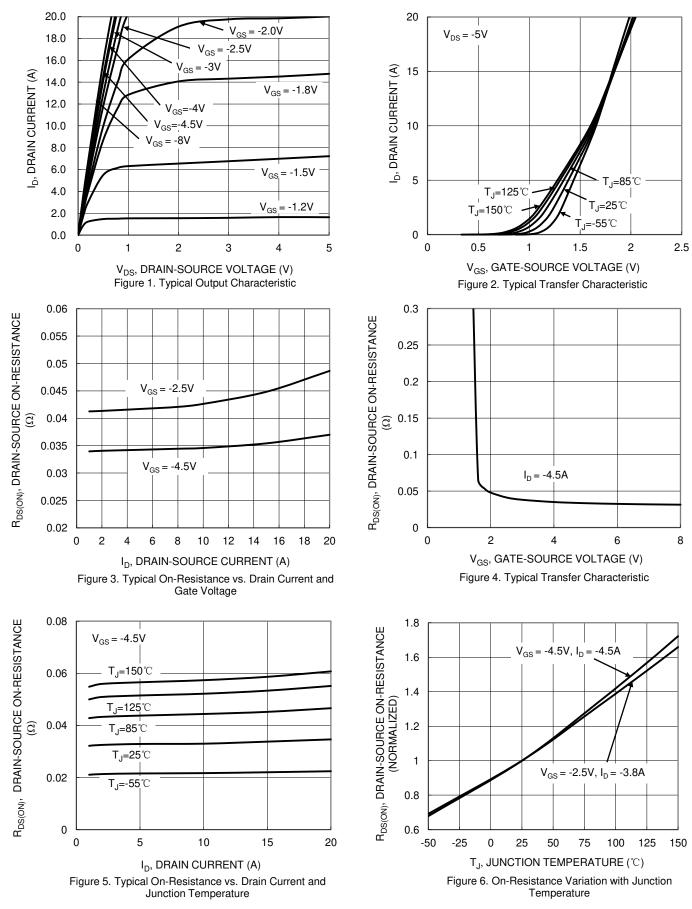
# Electrical Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	T. m	Мах	Unit	Test Condition	
STATIC PARAMETERS (Note 7)	Symbol	WIIN	Тур	max	Unit	Test Condition	
	51						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-20	—	—	V	$I_D = -250 \mu A, V_{GS} = 0 V$	
Zero Gate Voltage Drain Current $T_J = +25^{\circ}C$	I <sub>DSS</sub>		—	-1	μA	$V_{DS} = -16V, V_{GS} = 0V$	
Gate-Body Leakage Current	I <sub>GSS</sub>	_		±100	nA	$V_{DS}=0V, \ V_{GS}=\pm 8V$	
Gate Threshold Voltage	V <sub>GS(TH)</sub>	-0.4	—	-1.5	V	$V_{DS}=V_{GS},\ I_D=-250\mu A$	
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>		22 27	45 65	mΩ	$V_{GS} = -4.5V, I_D = -4.5A$ $V_{GS} = -2.5V, I_D = -3.8A$	
Diode Forward Voltage	V <sub>SD</sub>	_	-0.7	-1.4	V	I <sub>S</sub> = -2.1A, V <sub>GS</sub> = 0V	
DYNAMIC PARAMETERS (Note 8)			•	•	•		
Input Capacitance	C <sub>iss</sub>	_	1575	_	pF		
Output Capacitance	C <sub>oss</sub>	_	124	_	pF	V <sub>DS</sub> = -10V, V <sub>GS</sub> = 0V f = 1.0MHz	
Reverse Transfer Capacitance	C <sub>rss</sub>	_	89	_	pF		
Gate Resistance	Rg	_	10	_	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1MHz$	
Total Gate Charge (V <sub>GS</sub> = -4.5V)	Qg	_	15				
Total Gate Charge (V <sub>GS</sub> = -8V)	Qg	_	28		nC	V <sub>DS</sub> = -10V, I <sub>D</sub> = -4.5A	
Gate-Source Charge	Q <sub>gs</sub>	_	1.6	—		$v_{\rm DS} = -10v,  i_{\rm D} = -4.5 {\rm A}$	
Gate-Drain Charge	Q <sub>gd</sub>	_	3.4	_			
Turn-On Delay Time	t <sub>D(ON)</sub>	_	5.2	_			
Rise Time	t <sub>R</sub>	_	12			$V_{DS} = -5V, V_{GS} = -4.5V,$	
Turn-Off Delay Time	t <sub>D(OFF)</sub>	_	103		ns	$I_D = -1A, R_g = 6.0\Omega$	
Fall Time	t <sub>F</sub>		31	—			
Body Diode Reverse Recovery Time	t <sub>RR</sub>	_	13		ns	I <sub>F</sub> = -8.9A, di/dt = -100A/µs	
Body Diode Reverse Recovery Charge	Q <sub>RR</sub>	_	6.7		nC	I <sub>F</sub> = -8.9A, di/dt = -100A/µs	

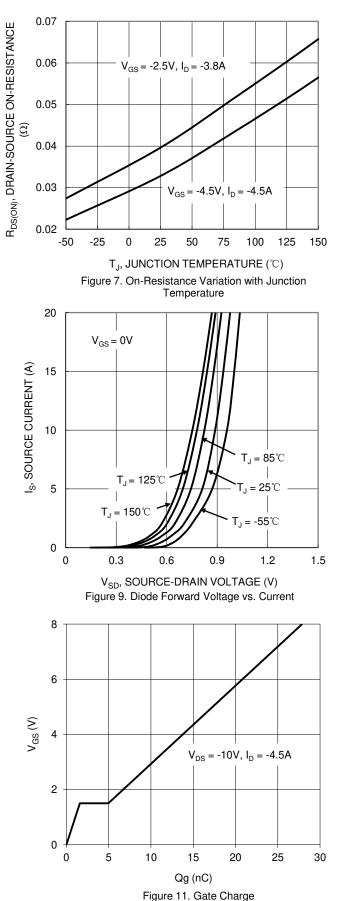
 Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
Short duration pulse test used to minimize self-heating effect.
Guaranteed by design. Not subject to product testing. Notes:

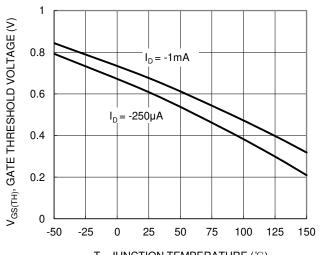


## DMP2067LVT









 $\label{eq:total_state} \begin{array}{l} \mathsf{T}_J, \mbox{JUNCTION TEMPERATURE} (^{\mathbb{C}}) \\ \mbox{Figure 8. Gate Threshold Variation vs. Junction} \\ \mbox{Temperature} \end{array}$ 

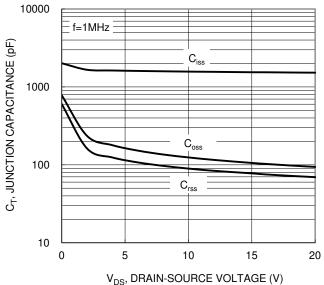


Figure 10. Typical Junction Capacitance

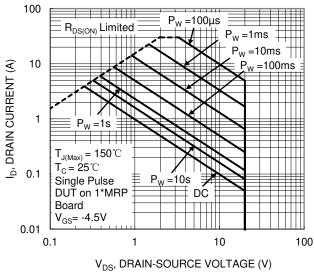


Figure 12. SOA, Safe Operation Area



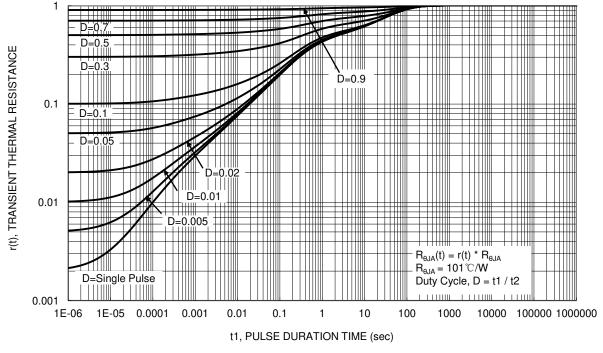
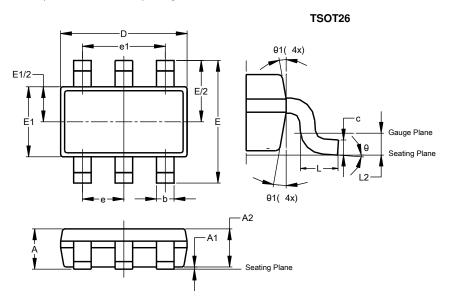


Figure 13. Transient Thermal Resistance



# **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.

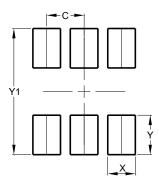


	TSOT26						
Dim	Min	Max	Тур				
Α	-	1.00	-				
A1	0.010	0.100	-				
A2	0.840	0.900	-				
D	2.800	3.000	2.900				
ш	2	.800 BS	С				
E1	1.500	1.700	1.600				
b	0.300	0.450	-				
С	0.120	0.200	-				
е	0.950 BSC						
e1	1	.900 BS	С				
_	0.30	0.50	-				
L2	0.250 BSC						
θ	0°	8°	4°				
θ1	4°	12°	-				
A	II Dimen	sions in	mm				

# **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.

TSOT26



Dimensions	Value (in mm)
С	0.950
Х	0.700
Y	1.000
Y1	3.199



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